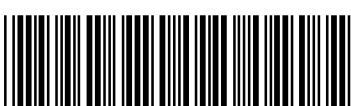


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10759325	PAFF ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Chun-Kuan Lee	2181

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
710	62	9/29/2008	CKL
380	44	9/29/2008	CKL
380	45	9/29/2008	CKL
380	46	9/29/2008	CKL
380	47	9/29/2008	CKL
380	278	9/29/2008	CKL
380	280	9/29/2008	CKL
380	281	9/29/2008	CKL
380	282	9/29/2008	CKL
380	283	9/29/2008	CKL
380	284	9/29/2008	CKL
380	285	9/29/2008	CKL
380	286	9/29/2008	CKL

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Updated EAST search:US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT	9/29/2008	CKL
Updated inventor search utilizing eDan and EAST	9/29/2008	CKL

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
710	62	9/29/2008	CKL
380	44	9/29/2008	CKL
380	45	9/29/2008	CKL
380	46	9/29/2008	CKL
380	47	9/29/2008	CKL
380	278	9/29/2008	CKL
380	279	9/29/2008	CKL
380	280	9/29/2008	CKL
380	281	9/29/2008	CKL
380	282	9/29/2008	CKL
380	283	9/29/2008	CKL

--	--

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
380	284	9/29/2008	CKL
380	285	9/29/2008	CKL
380	286	9/29/2008	CKL